TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSIII)

TPCS8204

Lithium Ion Battery Applications
Notebook PC Applications
Portable Equipment Applications

- Small footprint due to small and thin package
- Low drain-source ON resistance: $RDS(ON) = 13 \text{ m}\Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 15 \text{ S (typ.)}$
- Low leakage current: $IDSS = 10 \mu A (max) (VDS = 20 V)$
- Enhancement mode: $V_{th} = 0.5 \sim 1.2 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 200 \text{ }\mu\text{A})$

Absolute Maximum Ratings (Ta = 25°C)

Char	acteristics	Symbol	Rating	Unit	
Drain-source vol	tage	V _{DSS}	20	V	
Drain-gate voltag	je (R _{GS} = 20 kΩ)	V _{DGR}	20	V	
Gate-source volt	age	V _{GSS}	±12	V	
5	DC (Note 1)	I _D	6	Α	
Drain current	Pulse (Note 1)	I _{DP}	SS 20 GR 20 SS ±12 D 6 P 24 (1) 1.1 (2) 0.75 (1) 0.6 (2) 0.35 AS 46.8 R 6 AR 0.075	A	
Drain power dissipation	Single-device operation (Note 3a)	P _{D (1)}	1.1		
(t = 10 s) (Note 2a)	Single-device value at dual operation (Note 3b)	P _D (2)	0.75	W	
Drain power dissipation (t = 10 s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.6		
	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.35	W	
Single pulse avalanche energy (Note 4)		E _{AS}	46.8	mJ	
Avalanche current		I _{AR}	6	Α	
Repetitive avalanche energy Single-device value at dual operation (Note 2a, 3b, 5)		E _{AR}	0.075	mJ	
Channel temperature		T _{ch}	150	°C	
Storage tempera	ture range	T _{stg}	-55~150	°C	

Unit: mm

(0.525)

1. DRAIN 6 5. GATE
2. 3. SOURCE 6. 7. SOURCE
4. GATE 8. DRAIN

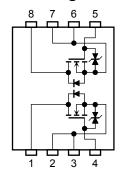
JEDEC —

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Weight: 0.035 g (typ.)

Circuit Configuration



Note: (Note 1), (Note 2), (Note 3), (Note 4) and (Note 5): See the next page.

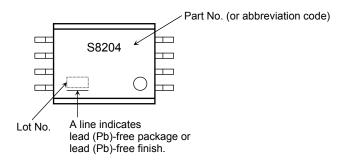
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Please handle with caution.

Thermal Characteristics

Characteristics	Symbol	Max	Unit		
Thermal resistance abancel to embient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	114	°C/W	
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	167		
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	208		
(t = 10 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	357	°C/W	

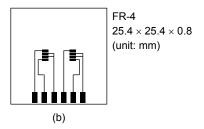
Marking (Note 6)



Note 1: Ensure that the channel temperature does not exceed 150°C.

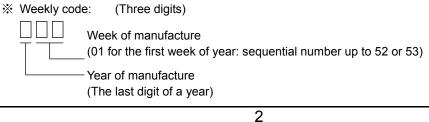
Note 2:

- a) Device mounted on a glass-epoxy board (a)
 - FR-4 25.4 × 25.4 × 0.8 (unit: mm)
- b) Device mounted on a glass-epoxy board (b)



Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device. (During single-device operation, power is only applied to one device.)
- b) The power dissipation and thermal resistance values are shown for a single device. (During dual operation, power is evenly applied to both devices.)
- Note 4: $V_{DD} = 16 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$ (initial), L = 1.0 mH, $R_G = 25 \Omega$, $I_{AR} = 6 \text{ A}$
- Note 5: Repetitive rating: pulse width limited by maximum channel temperature
- Note 6: on lower left of the marking indicates Pin 1.



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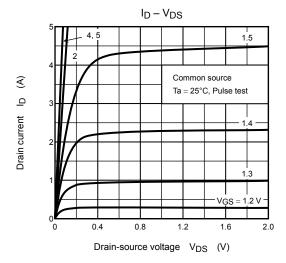
Electrical Characteristics (Ta = 25°C)

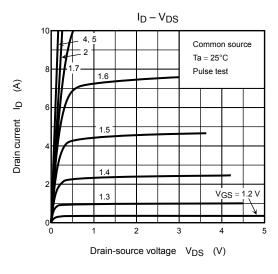
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 10 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cut-OFF cu	ırrent	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V	<u> </u>		μА	
Drain-source bre	akdown voltage	V _{(BR)DSS}	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$ 20		_		V
Diam-source bre	akdown vollage	V _{(BR)DSX}	$I_D = 10 \text{ mA}, V_{GS} = -12 \text{ V}$	8	_		٧
Gate threshold ve	oltage	V _{th}	$V_{DS} = 10 \text{ V}, I_D = 200 \mu\text{A}$	0.5	_	1.2	>
			$V_{GS} = 2.0 \text{ V}, I_D = 4.2 \text{ A}$		24	35	
Drain-source ON resistance		R _{DS} (ON)	$V_{GS} = 2.5 \text{ V}, I_D = 4.2 \text{ A}$	_	18	22	mΩ
			V _{GS} = 4.0 V, I _D = 4.8 A	_	13	17	
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 3.0 A	7.5	15	_	S
Input capacitance	Input capacitance		V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	2160	_	pF
Reverse transfer	Reverse transfer capacitance			_	210	_	
Output capacitance		Coss		_	230	_	
Switching time	Rise time	t _r	VGS 5 V	_	5	_	
	Turn-ON time	ton		l	13	ı	- ns
	Fall time	t _f		_	10	_	
	Turn-OFF time	t _{off}	$V_{DD} \simeq 10 \text{ V}$ Duty $\leq 1\%$, $t_W = 10 \mu\text{s}$	_	53	_	
Total gate charge (gate-source plus gate-drain)		Qg			22		
Gate-source charge 1		Q _{gs1}	$V_{DD} \simeq 16 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 6 \text{ A}$		4		nC
Gate-drain ("miller") charge		Q _{gd}			5		

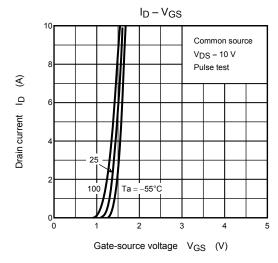
Source-Drain Ratings and Characteristics (Ta = 25°C)

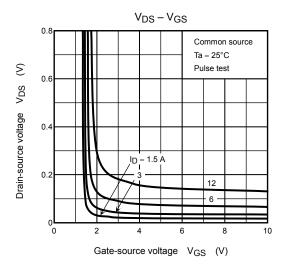
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	24	Α
Forward voltage (diode)		V _{DSF}	I _{DR} = 6 A, V _{GS} = 0 V	_	_	-1.2	V

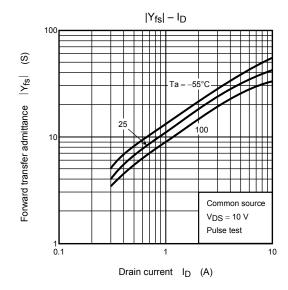
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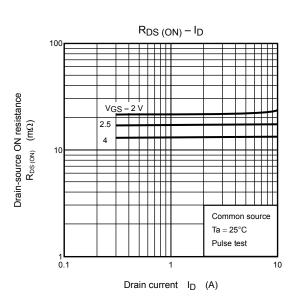


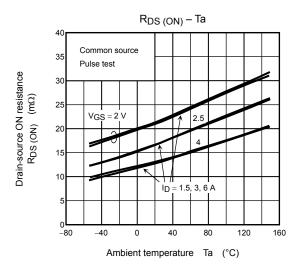


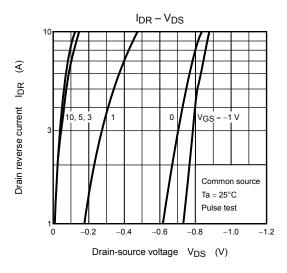


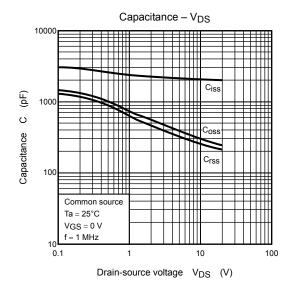


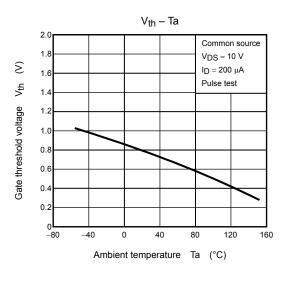


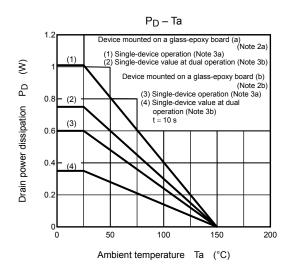


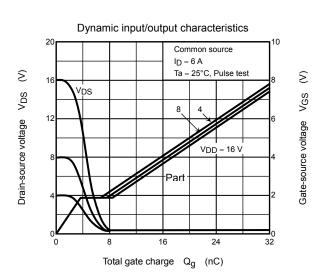


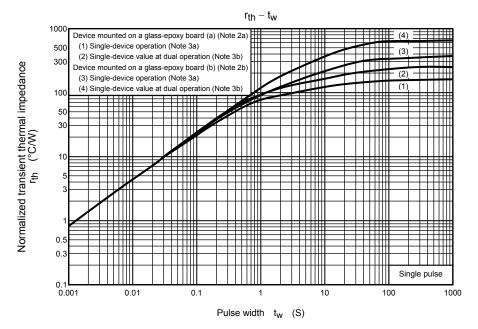




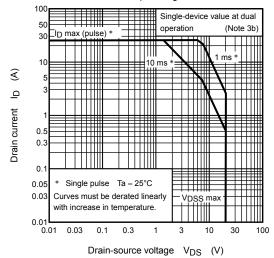












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